

1.8 – 2.8 GHz Gain Equilizer

Features

- Frequency Range : 1.8 2.8GHz
- 2.5dB Insertion Loss
- DC Decoupled Input/output
- No external matching required
- DC decoupled input and output
- 0.5 µm InGaAs pHEMT Technology
- Chip dimension: 1.2 x 1.6 x 0.1 mm

Functional Diagram



Typical Applications

- Gain Equalization
- Test Equipments

Description

The AMT2723011 is a 1.8 - 2.8GHz Gain Equalizer.

This Gain Equalizer features 2.5 dB of insertion loss. This Gain Equalizer offers 25dB of Negative Gain Slope Compensation. The die is fabricated using a reliable 0.5µm InGaAs pHEMT Technology. The Circuit grounds are provided through vias to the backside metallization.

Absolute Maximum Ratings ⁽¹⁾

Parameter	Absolute Maximum	Units
Drain bias voltage (Vd)	+10	volts
Drain current (Id)	90	mA
RF input power (RFin at Vd=9V)	23	dBm
Operating temperature	-50 to +85	°C
Storage Temperature	-65 to +150	°C

1. Operation beyond these limits may cause permanent damage to the component



Electrical Specifications ⁽¹⁾ @ $T_A = 25$ °C, $V_d = 8V$, Zo =50 Ω

Parameter	Тур.	Units
Frequency Range	1.8 - 2.8	GHz
Insertion Loss	2.5	dB
Gain Slope Compensation	25	dB
Input Return Loss	3	dB
Output Return Loss	3	dB
Supply Current	60	mA

Note:

1. Electrical specifications are measured in test fixture.



Test fixture data

 $V_d = 8V$, Total Current =60mA, $T_A = 25$ °C







Test fixture data

 $V_d = 8V$, Total Current =60mA, $T_A = 25 \,^{\circ}C$





Bond Pad Locations



Units: millimeters

Note:

- 1. All RF and DC bond pads are 100µm x 100µm
- 2. Pad no. 1 : RF IN
- 3. Pad no. 2 : Drain voltage(V_d)
- 4. Pad no. 5 : RF Output
- 5. Pad no. 6 : To be Grounded



Recommended Assembly Diagram



Note:

- Two 1 mil (0.0254mm) bond wires of minimum length should be used for RF input and 1. output.
- 2. Two 1 mil (0.0254mm) bond wires of minimum length should be used from chip bond pad to 100pF capacitor.
- Input and output 50 ohm lines are on 5 mil RT Duroid substrate З.
- 0.1 μ F capacitors may be additionally used as a second level of bypass for reliable 4. operation
- 5. The RF input & output ports are DC decoupled on-chip.
- 6. Proper heat sink like Copper tungsten or copper molybdenum to be used for better Reliability of chip

Die attach: For Epoxy attachment, use of a two-component conductive epoxy is recommended. An epoxy fillet should be visible around the total die periphery. If Eutectic attachment is preferred, use of fluxless AuSn (80/20) 1-2 mil thick preform solder is recommended. Use of AuGe preform should be strictly avoided.

Wire bonding: For DC pad connections use either ball or wedge bonds. For best RF performance, use of 150 - 200µm length of wedge bonds is advised. Single Ball bonds of 250-300µm though acceptable, may cause a deviation in RF performance.



GaAs MMIC devices are susceptible to Electrostatic discharge. Proper precautions should be observed during handling, assembly & testing

All information and Specifications are subject to change without prior notice